

Silicon Carbide (SiC) Module – 8 mohm SiC M3S MOSFET, 1200 V, 2-PACK Half Bridge Topology, F1 Package

NXH008P120M3F1PTNG, NXH008P120M3F1PNG

The NXH008P120M3F1 is a power module containing 8 mΩ / 1200 V SiC MOSFET half-bridge and a thermistor in an F1 package.

Features

- 8 mΩ / 1200 V M3S SiC MOSFET Half-Bridge
- Thermistor
- Options with Pre-Applied Thermal Interface Material (TIM) and without Pre-Applied TIM
- Press-Fit Pins
- These Devices are Pb-Free, Halide Free and are RoHS Compliant

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies
- Electric Vehicle Charging Stations
- Industrial Power

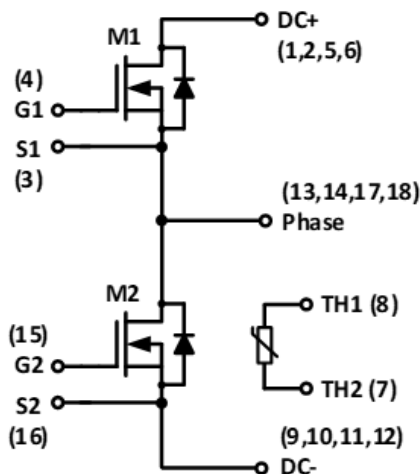
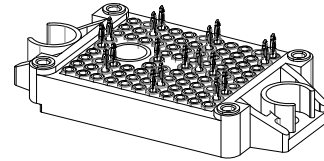


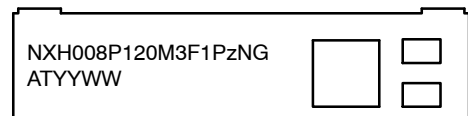
Figure 1. NXH008P120M3F1 Schematic Diagram

PACKAGE PICTURE



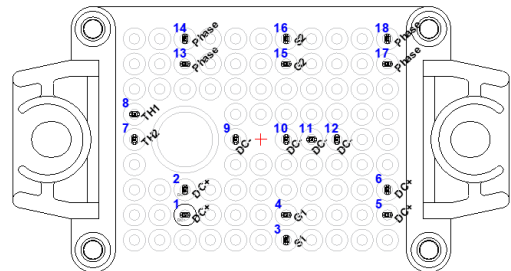
PIM18 33.8x42.5 (PRESS FIT)
CASE 180BW

MARKING DIAGRAM



NXH008P120M3F1PzNG = Specific Device Code
z = T (with TIM), blank (without TIM)
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

PIN CONNECTIONS



See Pin Function Description for pin names

ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

PIN FUNCTION DESCRIPTION

Pin	Name	Description
1	DC+	DC Positive Bus connection
2	DC+	DC Positive Bus connection
3	S1	M1 Kelvin Emitter (High side switch)
4	G1	M1 Gate (High side switch)
5	DC+	DC Positive Bus connection
6	DC+	DC Positive Bus connection
7	TH2	Thermistor Connection 2
8	TH1	Thermistor Connection 1
9	DC-	DC Negative Bus connection
10	DC-	DC Negative Bus connection
11	DC-	DC Negative Bus connection
12	DC-	DC Negative Bus connection
13	PHASE	Center point of half bridge
14	PHASE	Center point of half bridge
15	G2	M2 Gate (Low side switch)
16	S2	M2 Kelvin Emitter (Low side switch)
17	PHASE	Center point of half bridge
18	PHASE	Center point of half bridge



NXH008P120M3F1PTNG, NXH008P120M3F1PNG

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
SiC MOSFET			
Drain-Source Voltage	V_{DS}	1200	V
Gate-Source Voltage	V_{GS}	+22/-10	V
Continuous Drain Current @ $T_c = 80\text{ }^{\circ}\text{C}$ ($T_J = 175\text{ }^{\circ}\text{C}$) (Note 2)	I_D	200	A
Pulsed Drain Current ($T_J = 150\text{ }^{\circ}\text{C}$)	I_{Dpulse}	400	A
Maximum Power Dissipation ($T_J = 175\text{ }^{\circ}\text{C}$) (Note 2)	P_{tot}	790	W
Minimum Operating Junction Temperature	T_{JMIN}	-40	$^{\circ}\text{C}$
Maximum Operating Junction Temperature	T_{JMAX}	175	$^{\circ}\text{C}$

THERMAL PROPERTIES

Storage Temperature Range	T_{stg}	-40 to 150	$^{\circ}\text{C}$
TIM Layer Thickness for NXH008P120M3F1PTNG	T_{TIM}	80 ± 20	μm

INSULATION PROPERTIES

Isolation Test Voltage, $t = 1\text{ s}$, 60 Hz	V_{is}	4800	V_{RMS}
Creepage Distance		12.7	mm
CTI		600	
Substrate Ceramic Material		Si_3N_4	
Substrate Ceramic Material Thickness		0.32	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.
2. Maximum continuous current and power, without switching losses, to reach $T_J = 175\text{ }^{\circ}\text{C}$ defined by design based on MOSFET $R_{DS(ON)}$ and R_{thJC} and not subject to production test.

RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	-40	150	$^{\circ}\text{C}$

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
SiC MOSFET CHARACTERISTICS						
Zero Gate Voltage Drain Current	$V_{GS} = 0\text{ V}$, $V_{DS} = 1200\text{ V}$, $T_J = 25\text{ }^{\circ}\text{C}$	I_{DSS}	—	—	400	μA
Drain-Source On Resistance	$V_{GS} = 18\text{ V}$, $I_D = 120\text{ A}$, $T_J = 25\text{ }^{\circ}\text{C}$	$R_{DS(ON)}$	—	7.7	10.9	$\text{m}\Omega$
	$V_{GS} = 18\text{ V}$, $I_D = 120\text{ A}$, $T_J = 125\text{ }^{\circ}\text{C}$		—	12.6	—	
	$V_{GS} = 18\text{ V}$, $I_D = 120\text{ A}$, $T_J = 150\text{ }^{\circ}\text{C}$		—	14.4	—	
	$V_{GS} = 18\text{ V}$, $I_D = 120\text{ A}$, $T_J = 175\text{ }^{\circ}\text{C}$		—	18.1	—	
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 60\text{ mA}$	$V_{GS(TH)}$	2.04	2.4	4.4	V
Internal Gate Resistance		R_{GINT}	—	0.8	—	Ω
Gate Leakage Current	$V_{GS} = -10\text{ V} / 22\text{ V}$, $V_{DS} = 0\text{ V}$	I_{GSS}	-4	—	4	μA
Input Capacitance	$V_{DS} = 800\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	C_{ISS}	—	8334	—	pF
Reverse Transfer Capacitance		C_{RSS}	—	37	—	
Output Capacitance		C_{OSS}	—	472	—	



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ELECTRICAL CHARACTERISTICS (T_J = 25 °C unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
SIC MOSFET CHARACTERISTICS						
Total Gate Charge	V _{DS} = 800 V, V _{GS} = -3/18 V, I _D = 120 A	Q _{G(TOTAL)}	—	419	—	nC
Gate-Source Charge		Q _{GS}	—	61	—	nC
Gate-Drain Charge		Q _{GD}	—	96	—	nC
Turn-on Delay Time	T _J = 25 °C V _{DS} = 800 V, I _D = 120 A V _{GS} = -3 V / 18 V, R _G = 2 Ω	t _{d(on)}	—	17	—	ns
Rise Time		t _r	—	17	—	
Turn-off Delay Time		t _{d(off)}	—	97	—	
Fall Time		t _f	—	12	—	
Turn-on Switching Loss per Pulse		E _{ON}	—	1760	—	μJ
Turn-off Switching Loss per Pulse		E _{OFF}	—	588	—	
Turn-on Delay Time	T _J = 150 °C V _{DS} = 800 V, I _D = 120 A V _{GS} = -3 V / 18 V, R _G = 2 Ω	t _{d(on)}	—	15	—	ns
Rise Time		t _r	—	15	—	
Turn-off Delay Time		t _{d(off)}	—	110	—	
Fall Time		t _f	—	13	—	
Turn-on Switching Loss per Pulse		E _{ON}	—	2155	—	μJ
Turn-off Switching Loss per Pulse		E _{OFF}	—	745	—	
Diode Forward Voltage	V _{GS} = -3 V, I _{SD} = 120 A, T _J = 25 °C	V _{SD}	—	4.67	6.2	V
	V _{GS} = -3 V, I _{SD} = 120 A, T _J = 125 °C		—	4.45	—	
	V _{GS} = -3 V, I _{SD} = 120 A, T _J = 150 °C		—	4.4	—	
Thermal Resistance – Chip-to-Case	M1, M2	R _{thJC}	—	0.120	—	°C/W
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2 Mil +2%, A = 2.8 W/mK	R _{thJH}	—	0.356	—	°C/W

THERMISTOR CHARACTERISTICS

Nominal Resistance	T = 25 °C	R ₂₅	—	5	—	kΩ
	T = 100 °C	R ₁₀₀	—	493	—	Ω
	T = 150 °C	R ₁₅₀	—	159.5	—	Ω
Deviation of R ₁₀₀	T = 100 °C	ΔR/R	-5	—	5	%
Power Dissipation – Recommended Limit	0.15 mA, Non-self-heating Effect	P _D	—	0.1	—	mW
Power Dissipation – Absolute Maximum	5 mA	P _D	—	34.2	—	mW
Power Dissipation Constant			—	1.4	—	mW/K
B-value	B (25/50), tolerance ±2%		—	3375	—	K
B-value	B (25/100), tolerance ±2%		—	3436	—	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH008P120M3F1PTNG	NXH008P120M3F1PTNG	F1-PIM18 33.8 x 42.5 (PRESS FIT) Case 180BW with pre-applied thermal interface material (TIM) (Pb-Free / Halide Free)	28 Units / Blister Tray
NXH008P120M3F1PNG	NXH008P120M3F1PNG	F1-PIM18 33.8 x 42.5 (PRESS FIT) Case 180BW (Pb-Free / Halide Free)	28 Units / Blister Tray

TYPICAL CHARACTERISTIC
M1/M2 SiC MOSFET CHARACTERISTIC

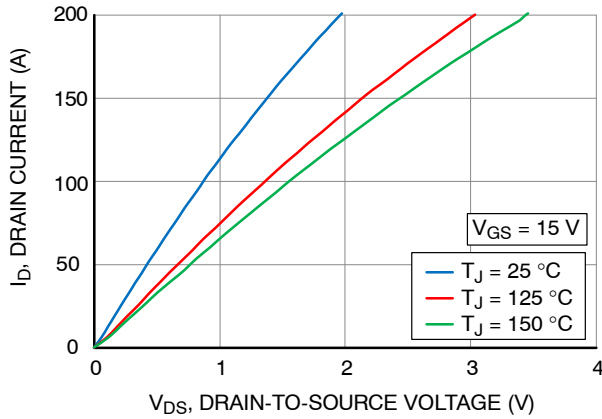


Figure 2. MOSFET Typical Output Characteristic $V_{GS} = 15\text{ V}$

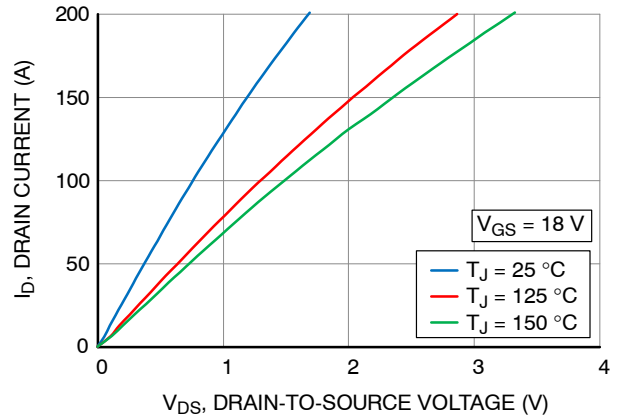


Figure 3. MOSFET Typical Output Characteristic $V_{GS} = 18\text{ V}$

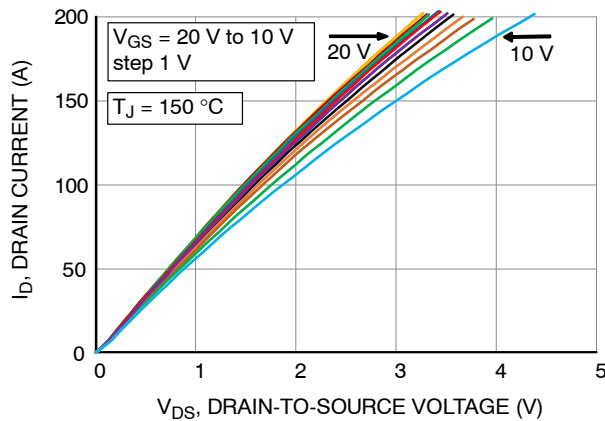


Figure 4. MOSFET Typical Output Characteristic $V_{GS} = \text{Var.}$

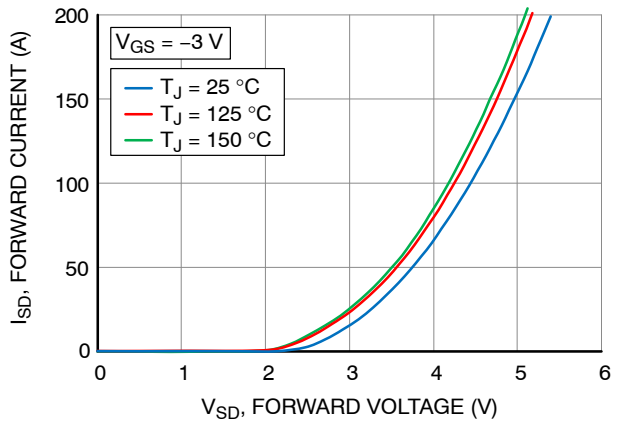


Figure 5. Body Diode Forward Characteristic

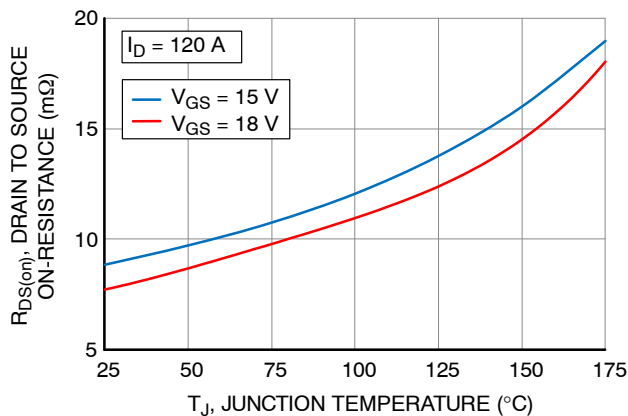


Figure 6. $R_{DS(on)}$ Drain-to-Source ON Resistance vs. Junction Temperature

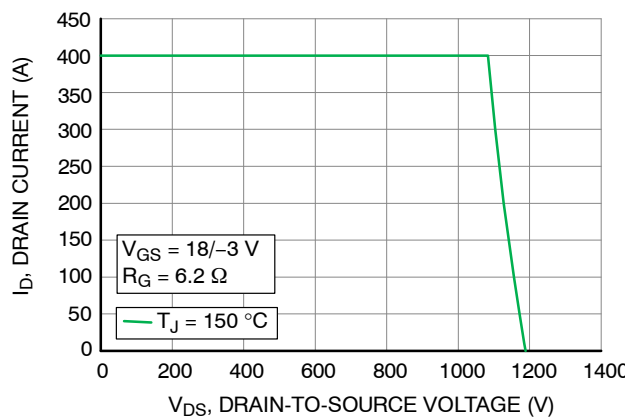


Figure 7. Reverse Bias Safe Operating Area (RBSOA)

TYPICAL CHARACTERISTICS (continued)

M1/M2 SIC MOSFET CHARACTERISTIC

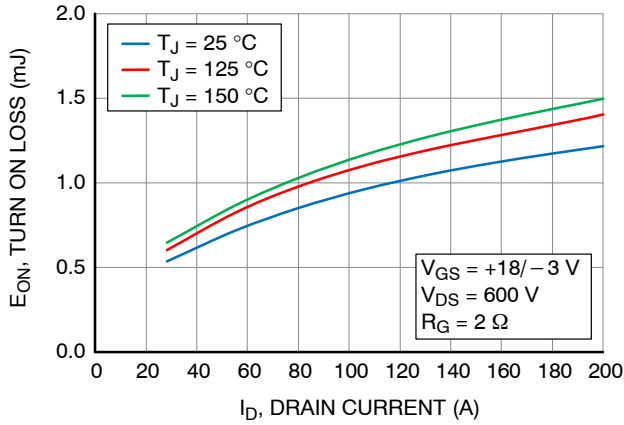


Figure 8. Switching on Loss vs. Drain Current $V_{DS} = 600$ V

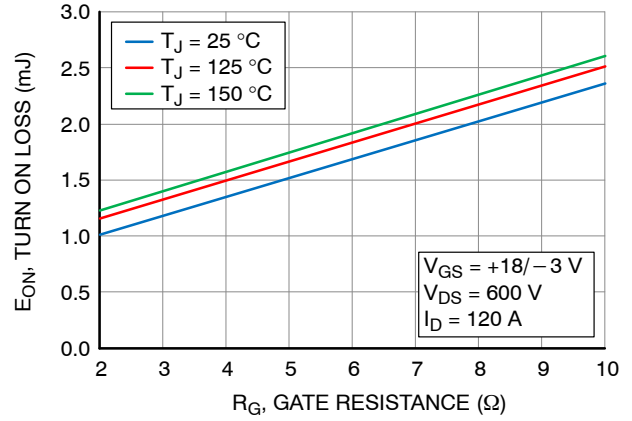


Figure 9. Switching on Loss vs. Gate Resistance $V_{DS} = 600$ V

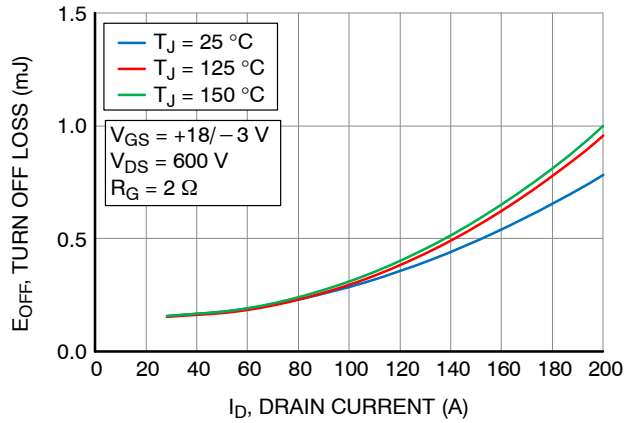


Figure 10. Switching off Loss vs. Drain Current $V_{DS} = 600$ V

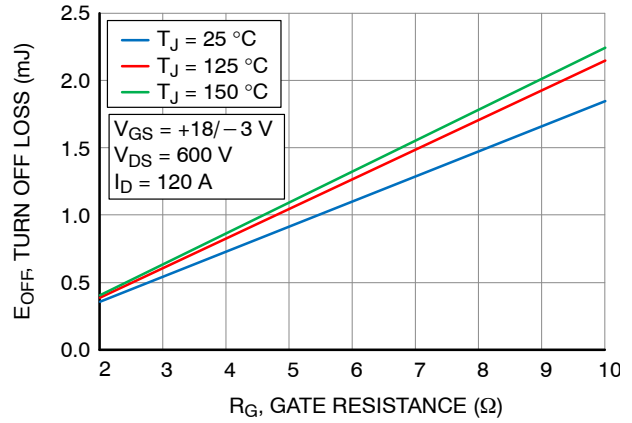


Figure 11. Switching off Loss vs. Gate Resistance $V_{DS} = 600$ V

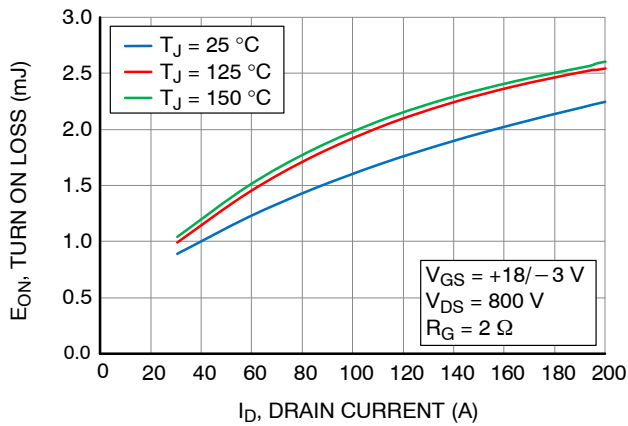


Figure 12. Switching on Loss vs. Drain Current $V_{DS} = 800$ V

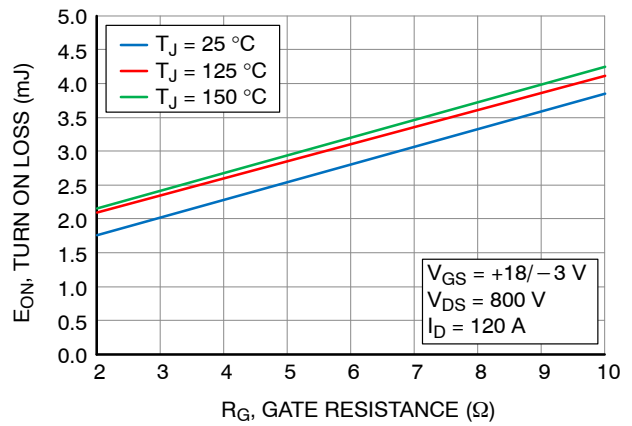


Figure 13. Switching on Loss vs. Gate Resistance $V_{DS} = 800$ V

TYPICAL CHARACTERISTICS (continued)

M1/M2 SIC MOSFET CHARACTERISTIC

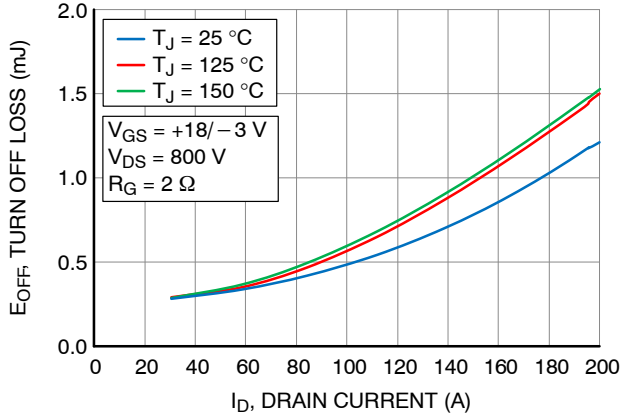


Figure 14. Switching off Loss vs. Drain Current $V_{DS} = 800 \text{ V}$

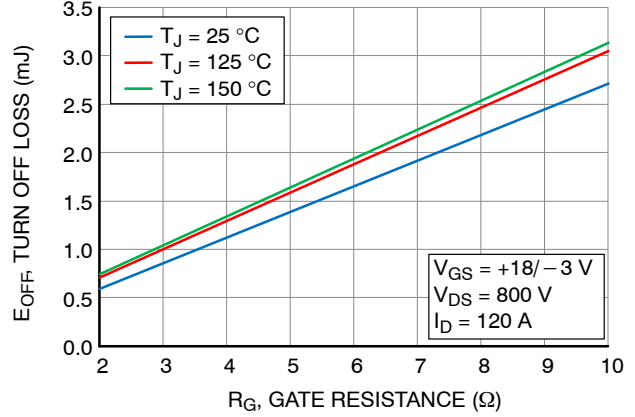


Figure 15. Switching off Loss vs. Gate Resistance $V_{DS} = 800 \text{ V}$

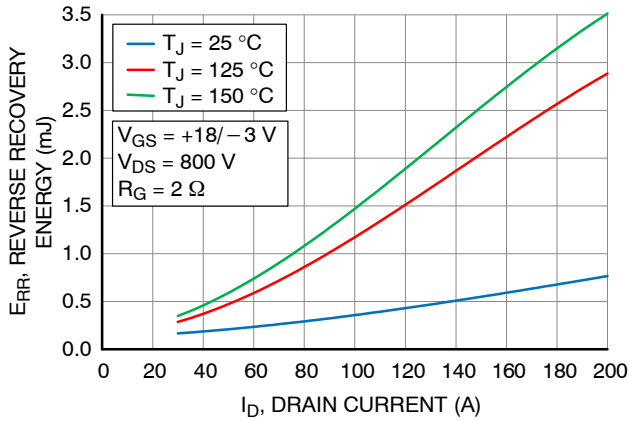


Figure 16. Reverse Recovery Energy vs. Drain Current $V_{DS} = 800 \text{ V}$

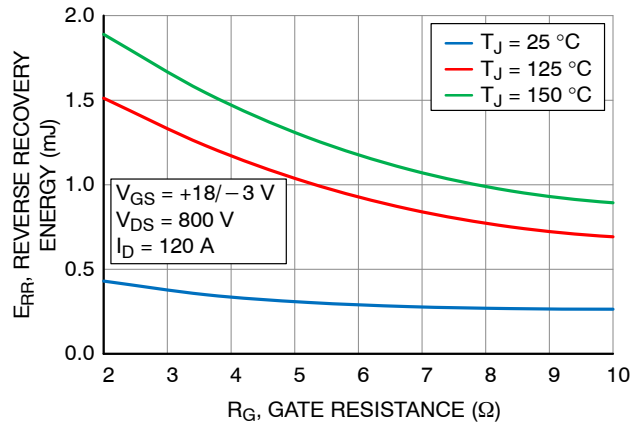


Figure 17. Reverse Recovery Energy vs. Gate Resistance $V_{DS} = 800 \text{ V}$

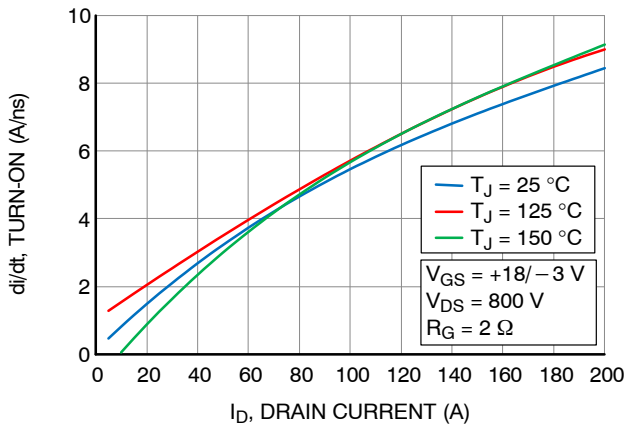


Figure 18. di/dt Turn ON vs. Drain Current $V_{DS} = 800 \text{ V}$

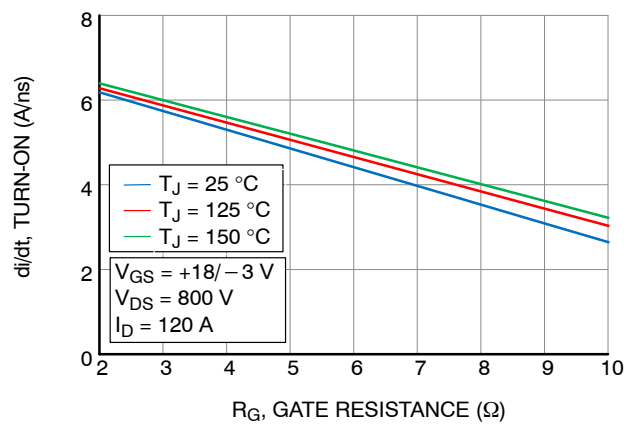


Figure 19. di/dt Turn ON vs. Gate Resistance $V_{DS} = 800 \text{ V}$



TYPICAL CHARACTERISTICS (continued)

M1/M2 SIC MOSFET CHARACTERISTIC

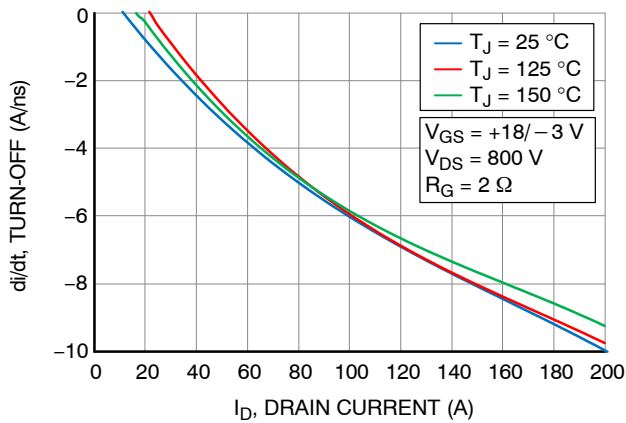


Figure 20. di/dt Turn OFF vs. Drain Current
 $V_{DS} = 800 \text{ V}$

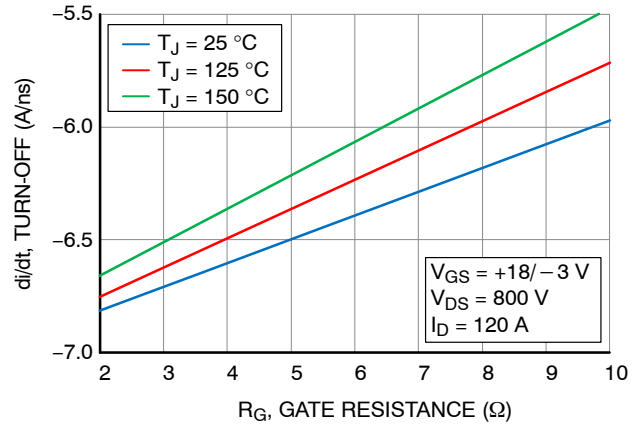


Figure 21. di/dt Turn OFF vs. Gate Resistance
 $V_{DS} = 800 \text{ V}$

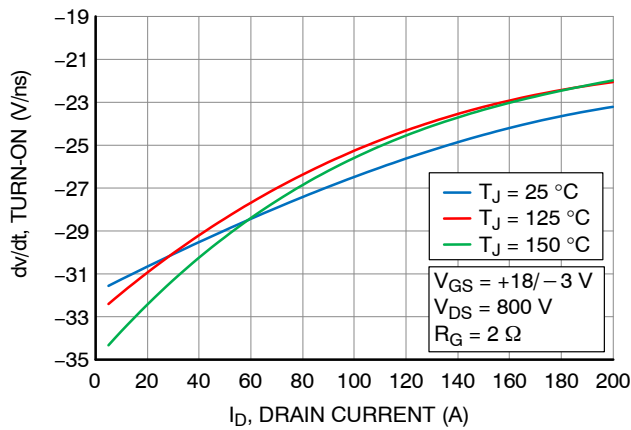


Figure 22. dv/dt Turn ON vs. Drain Current
 $V_{DS} = 800 \text{ V}$

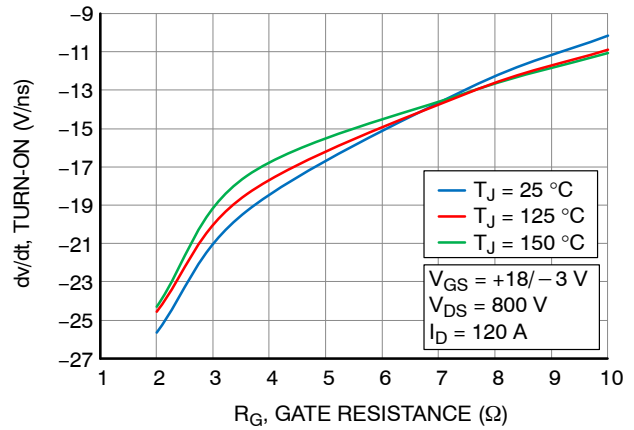


Figure 23. dv/dt Turn ON vs. Gate Resistance
 $V_{DS} = 800 \text{ V}$

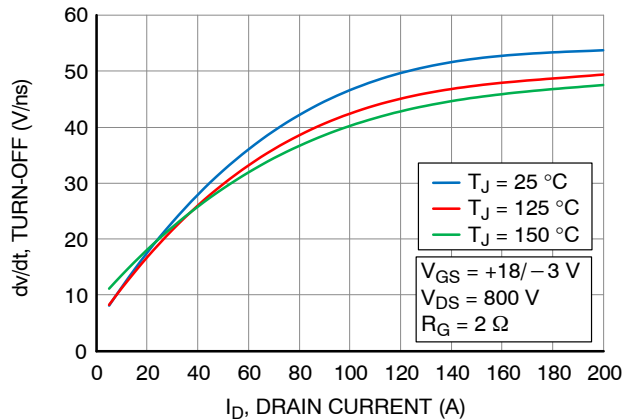


Figure 24. dv/dt Turn OFF vs. Drain Current
 $V_{DS} = 800 \text{ V}$

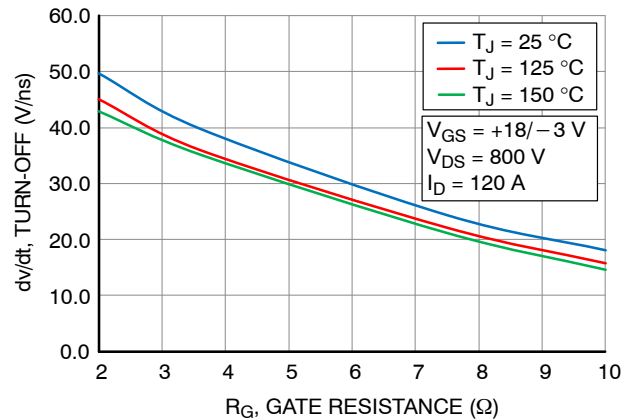


Figure 25. dv/dt Turn OFF vs. Gate Resistance
 $V_{DS} = 800 \text{ V}$

TYPICAL CHARACTERISTICS (continued)

M1/M2 SIC MOSFET CHARACTERISTIC

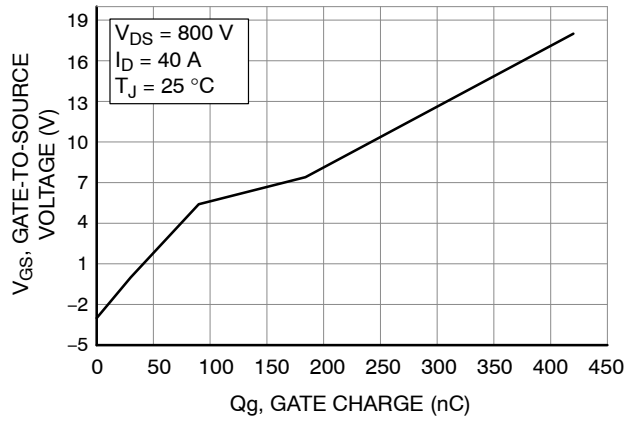


Figure 26. Gate-to-Source Voltage vs. Total Charge

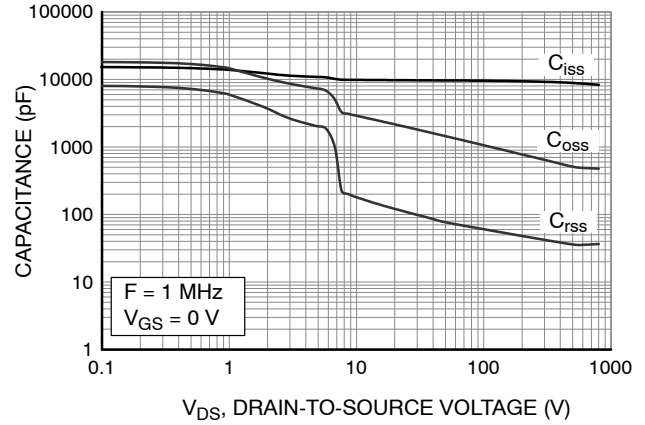


Figure 27. Capacitance vs. Drain-to-Source Voltage

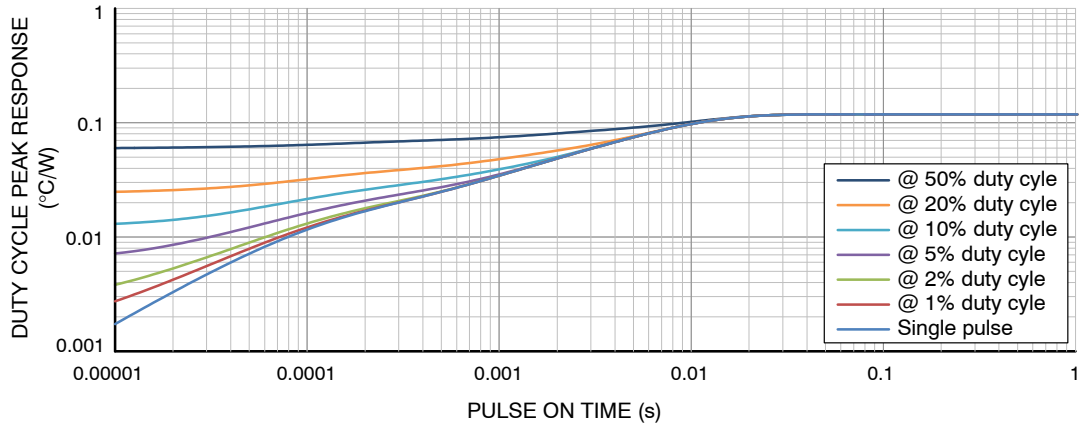
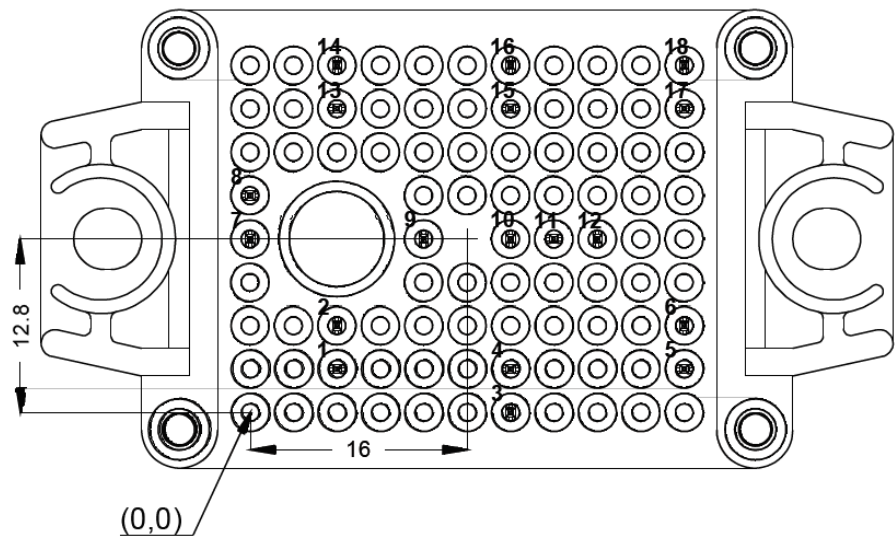


Figure 28. Duty Cycle Response vs. Pulse On Time

Table 1. THERMAL FOSTER NETWORKS

Foster Element #	Rth	Cth
1	0.012479	0.0065269
2	0.0007504	0.6245657
3	0.0143624	0.0719335
4	0.0908818	0.0750868

PIN POSITION INFORMATION



S Pin position

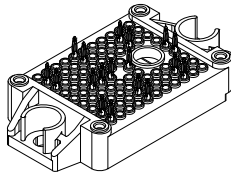
Pin #	X	Y	Function	Pin #	X	Y	Function
1	6.4	3.2	DC+	10	19.2	12.8	DC-
2	6.4	6.4	DC+	11	22.4	12.8	DC-
3	19.2	0.0	S1	12	25.6	12.8	DC-
4	19.2	3.2	G1	13	6.4	22.4	Phase
5	32.0	3.2	DC+	14	6.4	25.6	Phase
6	32.0	6.4	DC+	15	19.2	22.4	G2
7	0.0	12.8	TH2	16	19.2	25.6	S2
8	0.0	16.0	TH1	17	32.0	22.4	Phase
9	12.8	12.8	DC-	18	32.0	25.6	Phase

NXH008P120M3F1PTNG, NXH008P120M3F1PNG

REVISION HISTORY

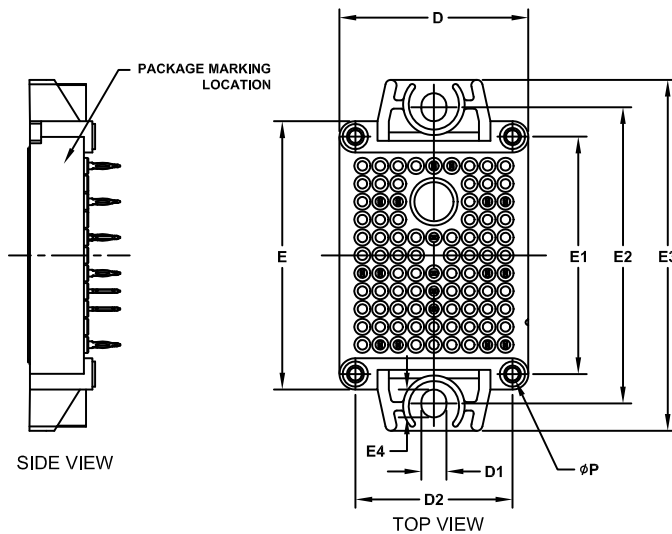
Revision	Description of Changes	Date
0	Initial document release.	9/18/2026





PIM18 33.8x42.5 (PRESS FIT)
CASE 180BW
ISSUE B

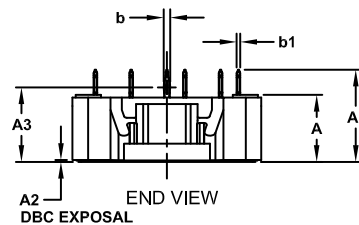
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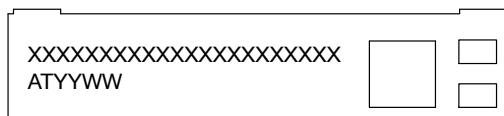
NOTES:

1. CONTROLLING DIMENSION: MILLIMETERS
2. PIN POSITION TOLERANCE IS $\pm 0.4\text{mm}$

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	11.65	12.00	12.35
A1	16.00	16.50	17.00
A2	0.00	0.35	0.60
A3	12.85	13.35	13.85
b	1.15	1.20	1.25
b1	0.59	0.64	0.69
D	33.50	33.80	34.10
D1	4.40	4.50	4.60
D2	27.95	28.10	28.25
E	47.70	48.00	48.30
E1	42.35	42.50	42.65
E2	52.90	53.00	53.10
E3	62.30	62.80	63.30
E4	4.90	5.00	5.10
P	2.20	2.30	2.40

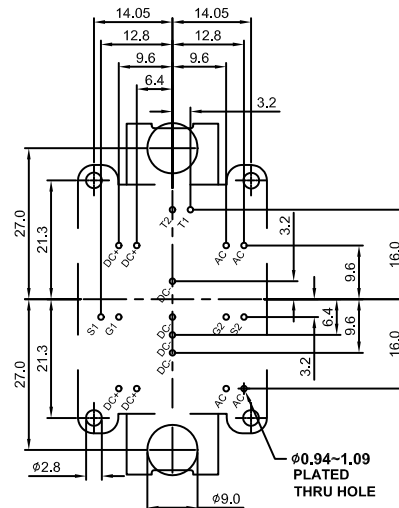


GENERIC
MARKING DIAGRAM*



XXXXX = Specific Device Code
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



RECOMMENDED
MOUNTING PATTERN

DOCUMENT NUMBER:	98AON19723H	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
DESCRIPTION:	PIM18 33.8x42.5 (PRESS FIT)	PAGE 1 OF 1

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